

July 2007

# **FDS9958** Dual P-Channel PowerTrench<sup>®</sup> MOSFET -60V, -2.9A, 105m $\Omega$

## Features

- Max  $r_{DS(on)} = 105 m\Omega$  at  $V_{GS} = -10V$ ,  $I_D = -2.9A$
- Max  $r_{DS(on)}$  =135m $\Omega$  at V<sub>GS</sub> = -4.5V, I<sub>D</sub> = -2.5A
- RoHS Compliant



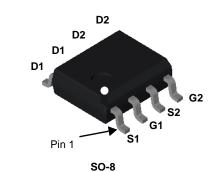
# **General Description**

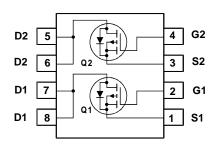
These P-channel logic level specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

These devices are well suited for portable electronics applications: load switching and power management, battery charging and protection circuits.

#### Applications

- Load Switch
- Power Management





# MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage		-60	V	
V <sub>GS</sub>	Gate to Source Voltage		±20	V	
I <sub>D</sub>	Drain Current -Continuous	(Note 1a)	-2.9		
	-Pulsed		-12	Α	
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 3)	54	mJ	
P <sub>D</sub>	Power Dissipation for Dual Operation		2		
	Power Dissipation	(Note 1a)	1.6	W	
	Power Dissipation	(Note 1b)	0.9		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C	

## **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	40	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	78	0/10

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS9958	FDS9958	SO-8	330mm	12mm	2500units

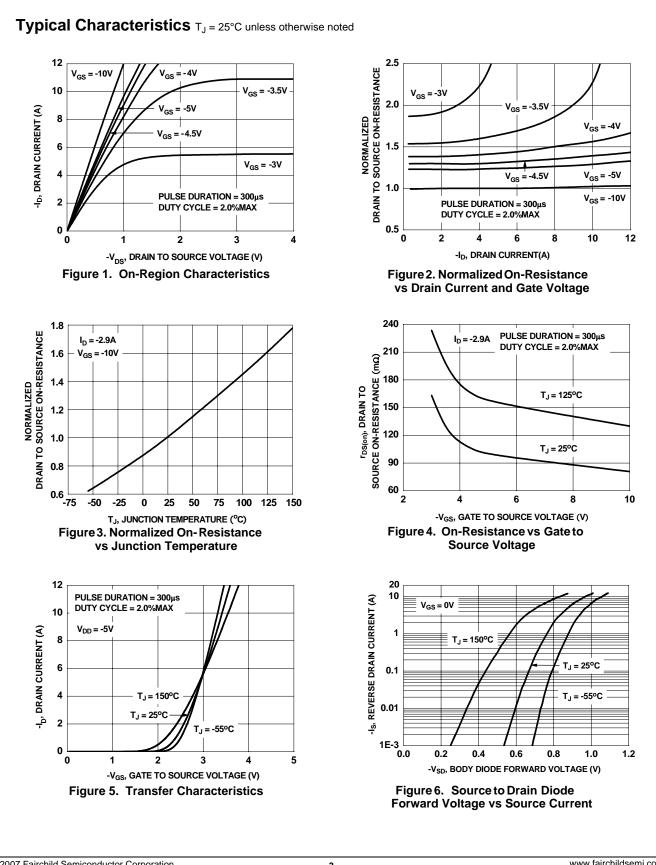
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ristics ain to Source Breakdown Voltage eakdown Voltage Temperature efficient ro Gate Voltage Drain Current te to Source Leakage Current ristics	$\begin{split} I_{D} &= -250 \mu A, \ V_{GS} = 0 V \\ I_{D} &= -250 \mu A, \ referenced \ to \ 25^{\circ}C \\ V_{DS} &= -48 V, \\ V_{GS} &= 0 V \\ T_{J} &= 125^{\circ}C \\ V_{GS} &= \pm 20 V, \ V_{DS} &= 0 V \end{split}$	-60	-52	-1 -100 ±100	V mV/°C μA
eakdown Voltage Temperature efficient ro Gate Voltage Drain Current te to Source Leakage Current	$I_D = -250 \mu A$ , referenced to 25°C $V_{DS} = -48V$ , $V_{GS} = 0V$ $T_J = 125°C$	-60	-52	-100	mV/°C
eakdown Voltage Temperature efficient ro Gate Voltage Drain Current te to Source Leakage Current	$I_D = -250 \mu A$ , referenced to 25°C $V_{DS} = -48V$ , $V_{GS} = 0V$ $T_J = 125°C$		-52	-100	
ro Gate Voltage Drain Current te to Source Leakage Current	$V_{GS} = 0V$ $T_J = 125^{\circ}C$			-100	μΑ
	$V_{GS} = \pm 20V, V_{DS} = 0V$				
istics				±100	nA
151105					
te de Oerone e Thursela de Velderes		4.0	4.0		N
te to Source Threshold Voltage	$V_{GS} = V_{DS}, \ I_D = -250 \mu A$	-1.0	-1.6	-3.0	V
6	$I_D = -250\mu A$ , referenced to $25^{\circ}C$		4		mV/°C
	V <sub>GS</sub> = -10V, I <sub>D</sub> = -2.9A		82	105	
Static Drain to Source On Resistance	$V_{GS} = -4.5V, I_{D} = -2.5A$		103	135	mΩ
	V <sub>GS</sub> = -10V, I <sub>D</sub> = -2.9A, T <sub>J</sub> = 125°C		131	190	
rward Transconductance	$V_{DD} = -5V, I_D = -2.9A$		7.7		S
racteristics					
			765	1020	pF
	50 00		90	120	pF
	f = 1MHz		40	65	pF
maracteristics			6	12	ns
	V <sub>DD</sub> = -30V, I <sub>D</sub> = -2.9A,				ns
	$V_{GS} = -10V, R_{GEN} = 6\Omega$		-		ns
					ns
	$V_{CC} = 0V \text{ to } -10V$		-		nC
· · · · · · · · · · · · · · · · · · ·	$V_{CS} = 0V \text{ to } -4.5V$ $V_{DD} = -30V$ ,				nC
0	I <sub>D</sub> = -2.9A		-		nC
te to Drain "Miller" Charge	-		3		nC
			I	I	
urce to Drain Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = -1.3A (Note 2)		-0.8	-1.2	V
			26	42	ns
verse Recovery Time	— I <sub>F</sub> = -2.9A, di/dt = 100A/μs		20	42	115
	ward Transconductance racteristics ut Capacitance tput Capacitance verse Transfer Capacitance raracteristics m-On Delay Time e Time n-Off Delay Time I Time al Gate Charge al Gate Charge te to Source Charge te to Drain "Miller" Charge Diode Characteristics	ID-250µA, referenced to 25°CID $I_D = -250µA$ , referenced to 25°CItic Drain to Source On Resistance $V_{GS} = -10V, I_D = -2.9A$ VGS $-4.5V, I_D = -2.9A$ VGS $-10V, I_D = -2.9A, T_J = 125°C$ Ward Transconductance $V_{DD} = -5V, I_D = -2.9A$ It Capacitance $V_{DD} = -5V, I_D = -2.9A$ It Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ It Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ It Capacitance $V_{DD} = -30V, I_D = -2.9A, V_{GS} = 0V, f = 10HHz$ It Capacitance $V_{DD} = -30V, I_D = -2.9A, V_{GS} = 0V, f = 10HHz$ It TimeIt TimeIt Time $V_{GS} = 0V to -10V, V_{GS} = 0V to -10V, I_D = -2.9A, V_{GS} = 0V to -10V, I$	Ip = -250 \muA, referenced to 25°Ctic Drain to Source On Resistance $V_{GS} = -10V, I_D = -2.9A$ $V_{GS} = -10V, I_D = -2.9A, T_J = 125°Cward TransconductanceV_{DD} = -5V, I_D = -2.9Award TransconductanceV_{DD} = -5V, I_D = -2.9Award TransconductanceV_{DS} = -30V, V_{GS} = 0V, f = 1MHztu CapacitanceV_{DS} = -30V, V_{GS} = 0V, f = 1MHzwaracteristicsV_{DD} = -30V, I_D = -2.9A, V_{GS} = 0V, f = 10HHzmonon Delay TimeV_{DD} = -30V, I_D = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omegaa Gate ChargeV_{GS} = 0V \text{ to } -10V, I_D = -2.9A, I_D = -2.9A, V_{GS} = -10V, R_{GEN} = 6\Omegaa Gate ChargeV_{GS} = 0V \text{ to } -4.5V, I_D = -2.9A, I_D = -2.9$	Inperature CoefficientID $I_D = -2.90 \mu A$ , referenced to 25°C4Itic Drain to Source On Resistance $V_{GS} = -10V, I_D = -2.9A$ 82VGS = -10V, I_D = -2.9A103VGS = -10V, I_D = -2.9A, T_J = 125°C131Ward Transconductance $V_{DD} = -5V, I_D = -2.9A$ 7.7Itic Capacitance $V_{DD} = -5V, I_D = -2.9A$ 765Itic Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ 90Itic Capacitance $V_{DS} = -30V, V_{GS} = 0V, f = 1MHz$ 90Itime $V_{DD} = -30V, I_D = -2.9A, V_{GS} = 0V, f = 10V, R_{GEN} = 6\Omega$ 6Itime $V_{DD} = -30V, I_D = -2.9A, V_{GS} = 0V, f = 10V, R_{GEN} = 6\Omega$ 27Itime $V_{GS} = 0V \text{ to } -10V, I_D = -30V, I_D = -2.9A8ItimeItimeItime116Id Gate ChargeV_{GS} = 0V to -4.5VV_{DD} = -30V, I_D = -2.9A8It to Source ChargeItimeItime3It to Drain "Miller" ChargeItimeItime3IDiode CharacteristicsItimeItimeItime$	Inperature Coefficient       ID $-250\mu$ A, referenced to $25^{\circ}$ C       4         Inperature Coefficient       V <sub>GS</sub> = -10V, ID = -2.9A       82       105         VGS = -4.5V, ID = -2.9A, TJ = 125°C       103       135         VGS = -10V, ID = -2.9A, TJ = 125°C       131       190         ward Transconductance       VDD = -5V, ID = -2.9A, TJ = 125°C       131       190         tracteristics         ut Capacitance       VDD = -5V, ID = -2.9A       7.7         tracteristics         ut Capacitance       VDS = -30V, VGS = 0V, f = 10Hz       90       120         verse Transfer Capacitance       F = 10HHz       40       65         aracteristics         n-On Delay Time       VDD = -30V, ID = -2.9A, VGS = 0V, GS = -10V, RGEN = 6Ω       3       10         n-Off Delay Time       VGS = -10V, RGEN = 6Ω       277       43         1 Time       6       12       2       6       12         al Gate Charge       VGS = 0V to -10V       VDD = -30V, ID = -2.9A       8       12         te to Source Charge       VGS = 0V to -4.5V       VDD = -30V, ID = -2.9A       3       16       23         Et to Source Charge       VGS = 0V to -4.5V       VD = -2.9A       2

2. Pulse Test: Pulse Width <  $300\mu$ s, Duty cycle < 2.0%.

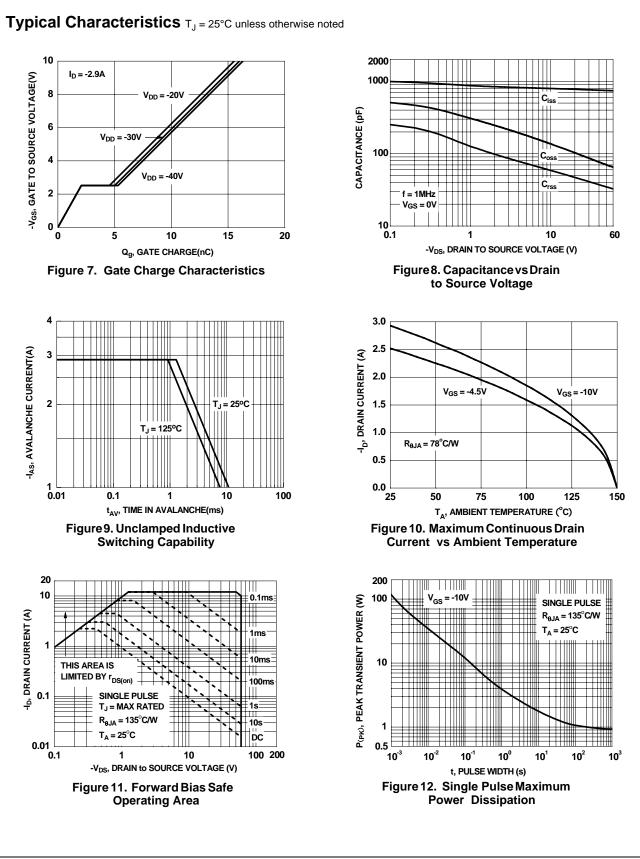
3. UIL condition: Starting  $T_J$  = 25°C, L = 3mH,  $I_{AS}$  = 6A,  $V_{DD}$  = 60V,  $V_{GS}$  = 10V.

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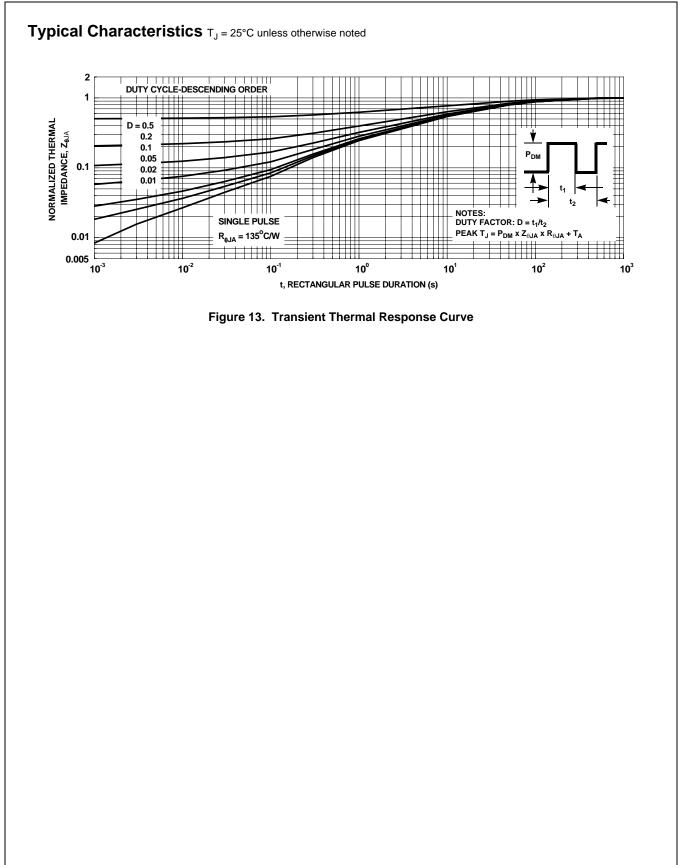
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